

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/532,282	KIJAK ET AL.	
Examiner		Art Unit		Page 1 of 3
HEE-YONG KIM		4192		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6774917	08-2004	Foote	345/700
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Paul E. Green: "Analyzing Multivariate Data", The Dryden Press, 1978, ISBN 0-03-020786-x
*	V	Paul S. Bradley et al.: "Refining Initial Points for K-Means Clustering", Microsoft Research Technical Report 1998, pp.3-4)
*	W	Palmer: "Density Biased Sampling: An Improved Method for Data Mining and Clustering", Processing of ACM SIGMOD International Conference on Management of Data, 2000
*	X	Turi et al.: "K-Means Clustering for Colour Image Segmentation with Detection of K", Proceedings of the LASTED international Conference Signal and Image Processing, Oct, 1998, pp.345-349

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/532,282	KIJAK ET AL.	
Examiner		Art Unit		Page 2 of 3
HEE-YONG KIM		4192		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Wan et al.: "A multiresolution color clustering approach to image indexing and retrieval", Proceedings of 1998 IEEE International Conference, pp.3705-3708
*	V	J.M. Pena et al: "An empirical comparison of four initialization methods for the K-Means algorithm", Pattern Recognition Letters 20(1999) 1027-1040
*	W	Khan et al: "Cluster center initialization algorithm for K-means clustering", Pattern Recognition Letters 25 (2004) 1293-1302
*	X	Ji He et al: "Initialization of Cluster Refinement Algorithms: A Review and Comparative Study", Proceedings of Int'l Conference on Neural Networks, July 2004 Vol.1, pp.297-302.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/532,282	KIJAK ET AL.	
Examiner HEE-YONG KIM		Art Unit 4192	Page 3 of 3	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Douglas Steinley:"Initializing K-means Batch Clustering: A Critical Evaluation of Several Techniques",Journal of Classification Vol 24:pp.99-121, 2007
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.